



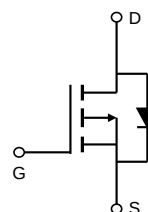
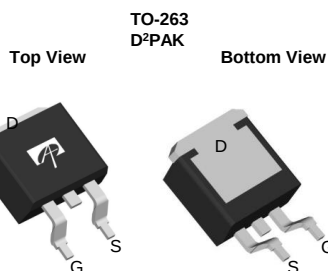
General Description

The AOB409L combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

V_{DS}	-60V
I_D (at $V_{GS}=-10V$)	-31.5A
$R_{DS(ON)}$ (at $V_{GS}=-10V$)	< 38m Ω
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	< 50m Ω

100% UIS Tested
100% R_g Tested



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	-60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$ -31.5	A
		$T_C=100^\circ\text{C}$ -22	
Pulsed Drain Current ^C	I_{DM}	-85	
Continuous Drain Current	I_{DSM}	$T_A=25^\circ\text{C}$ -5	A
		$T_A=70^\circ\text{C}$ -4	
Avalanche Current ^C	I_{AS}, I_{AR}	37	A
Avalanche energy $L=0.1\text{mH}$ ^C	E_{AS}, E_{AR}	68	mJ
Power Dissipation ^B	P_D	$T_C=25^\circ\text{C}$ 83.3	W
		$T_C=100^\circ\text{C}$ 41.6	
Power Dissipation ^A	P_{DSM}	$T_A=25^\circ\text{C}$ 2.1	W
		$T_A=70^\circ\text{C}$ 1.3	
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	$t \leq 10\text{s}$ 11	15	$^\circ\text{C/W}$
Maximum Junction-to-Ambient ^{A,D}		Steady-State 47	60	$^\circ\text{C/W}$
Maximum Junction-to-Case	$R_{\theta JC}$	1.5	1.8	$^\circ\text{C/W}$

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V	-60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-60V, V _{GS} =0V T _J =55°C			-1 -5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250μA	-1.2	-2.1	-2.4	V
I _{D(ON)}	On state drain current	V _{GS} =-10V, V _{DS} =-5V	-85			A
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-10V, I _D =-20A T _J =125°C		30 53	38 66	mΩ
		V _{GS} =-4.5V, I _D =-20A		39	50	mΩ
g _{FS}	Forward Transconductance	V _{DS} =-5V, I _D =-20A		32		S
V _{SD}	Diode Forward Voltage	I _S =-1A, V _{GS} =0V		-0.72	-1	V
I _S	Maximum Body-Diode Continuous Current ^G				60	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-30V, f=1MHz	1969	2461	2953	pF
C _{oss}	Output Capacitance		125	178	231	pF
C _{rss}	Reverse Transfer Capacitance		72	120	168	pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2	4	Ω
SWITCHING PARAMETERS						
Q _{g(10V)}	Total Gate Charge	V _{GS} =-10V, V _{DS} =-30V, I _D =-20A	34	43	52	nC
Q _{g(4.5V)}	Total Gate Charge		16	19.7	24	nC
Q _{gs}	Gate Source Charge		8	10.2	12	nC
Q _{gd}	Gate Drain Charge		5	8.9	12.5	nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =-10V, V _{DS} =-30V, R _L =1.5Ω, R _{GEN} =3Ω		12		ns
t _r	Turn-On Rise Time			14.5		ns
t _{D(off)}	Turn-Off DelayTime			38		ns
t _f	Turn-Off Fall Time			15		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-20A, dI/dt=500A/μs	18	25.7	33	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-20A, dI/dt=500A/μs	117	167	217	nC

A. The value of R_{DS(on)} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{DS(on)} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The R_{DS(on)} is the sum of the thermal impedance from junction to case R_{DS(on)} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current limited by package.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

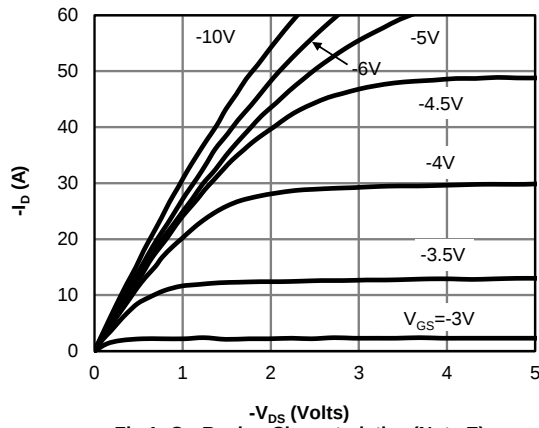


Fig 1: On-Region Characteristics (Note E)

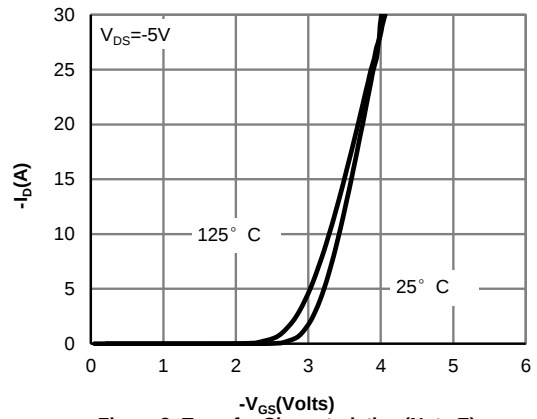


Figure 2: Transfer Characteristics (Note E)

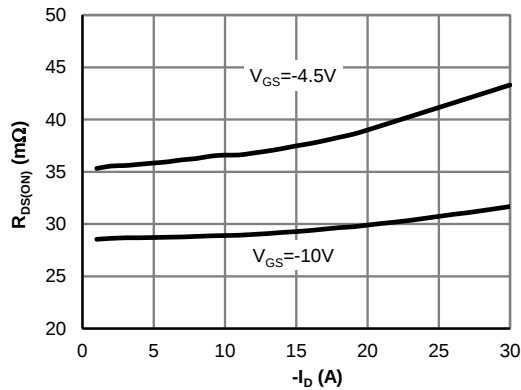


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

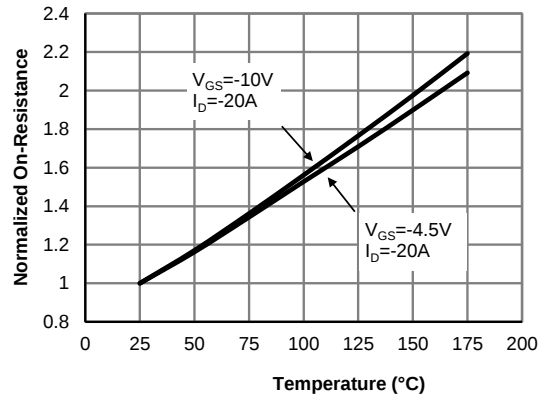


Figure 4: On-Resistance vs. Junction Temperature (Note E)

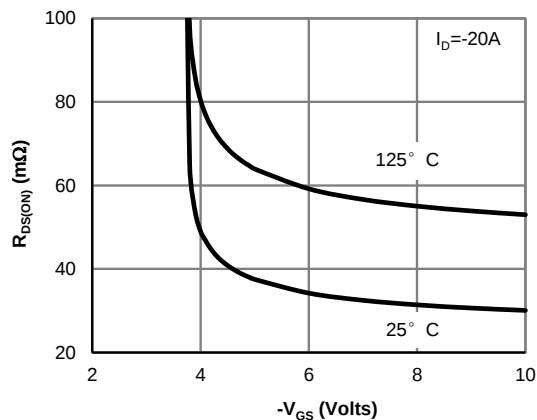


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

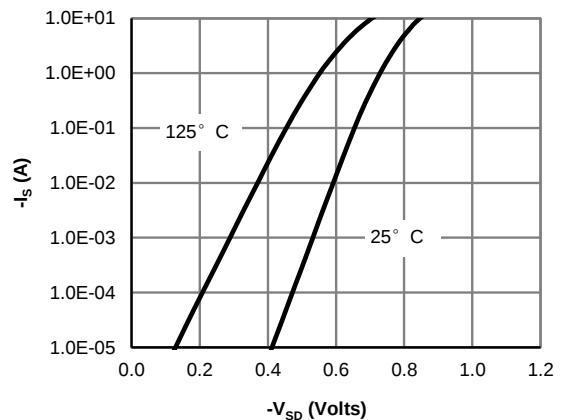
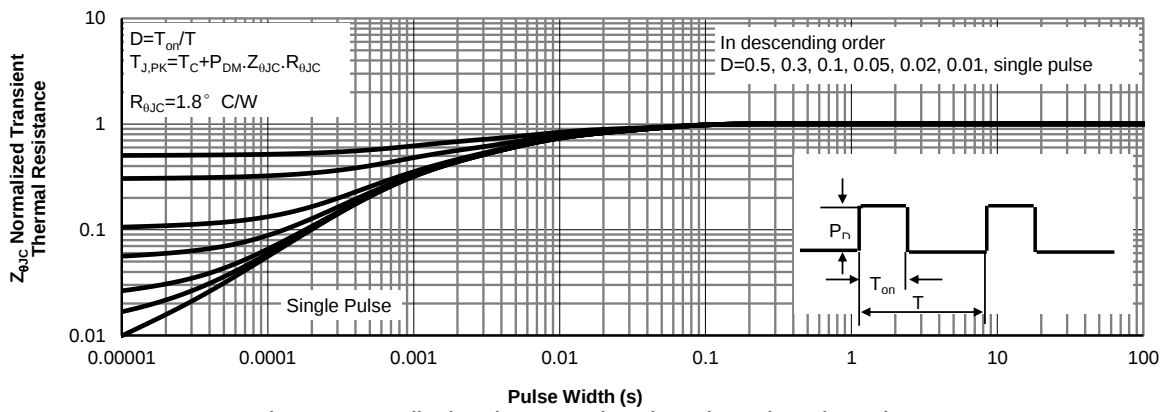
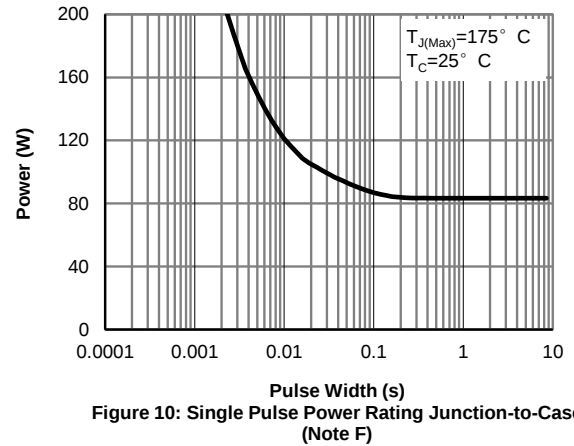
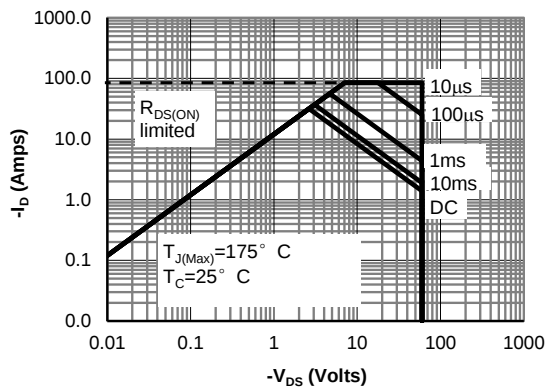
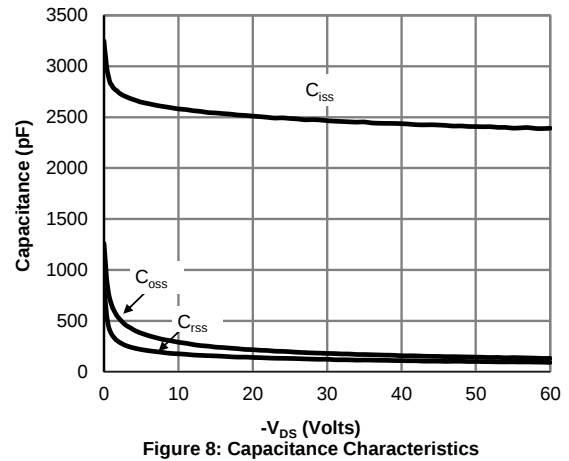
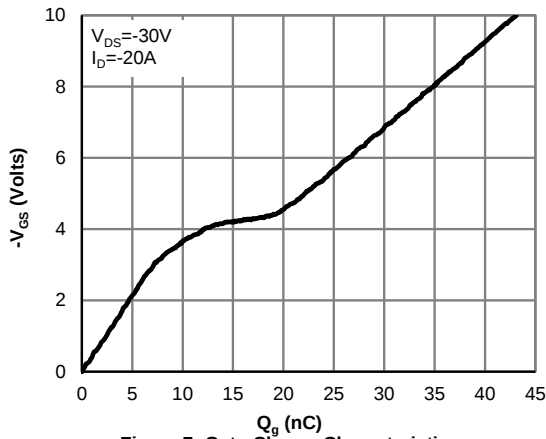


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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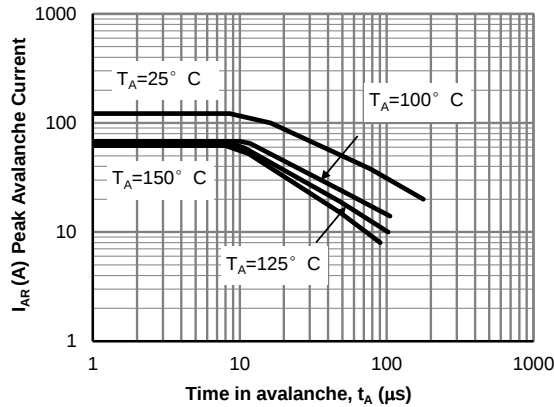


Figure 12: Single Pulse Avalanche capability (Note C)

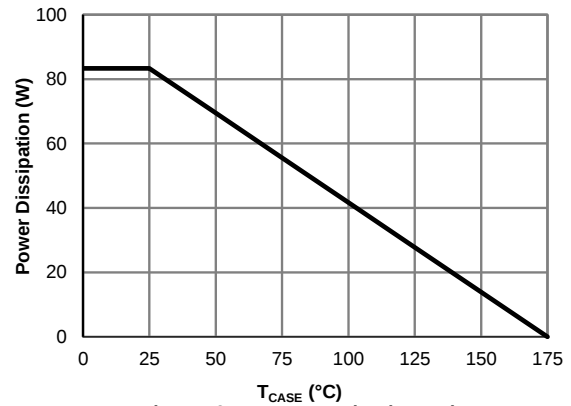


Figure 13: Power De-rating (Note F)

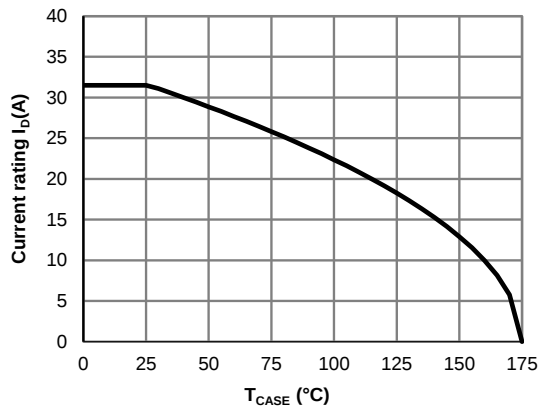


Figure 14: Current De-rating (Note F)

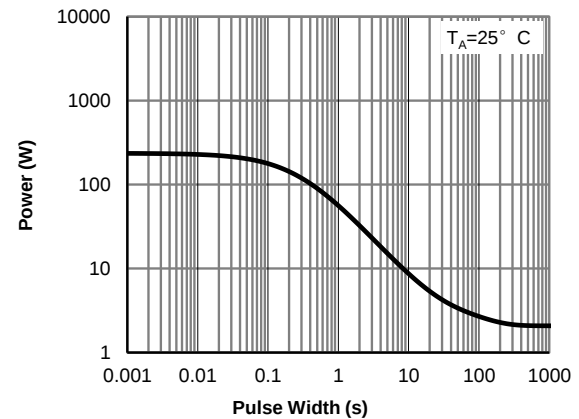


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

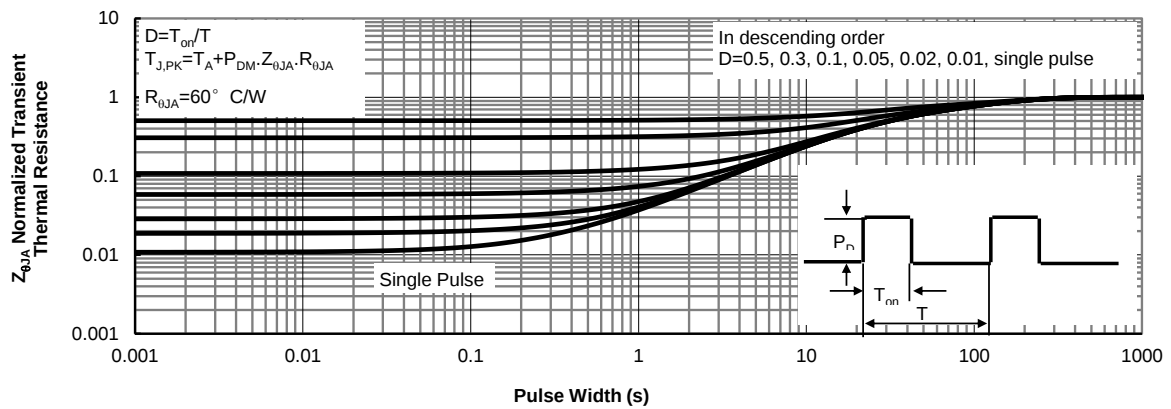
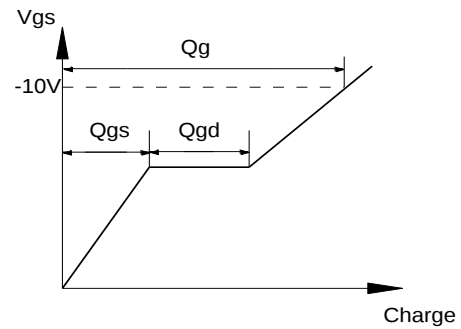
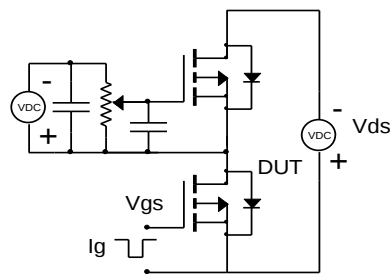
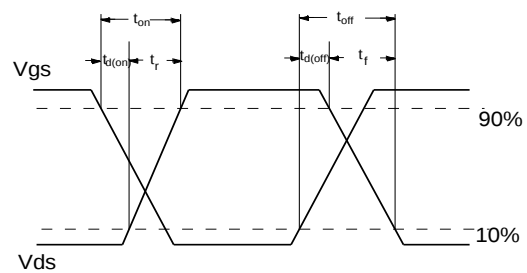
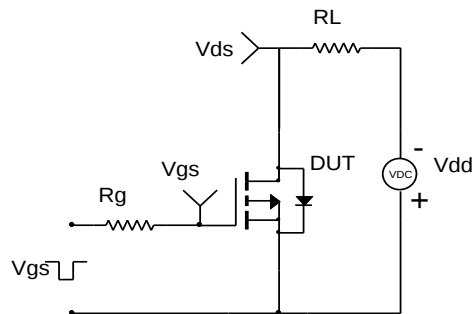


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

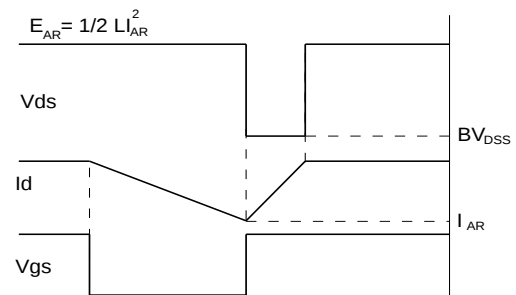
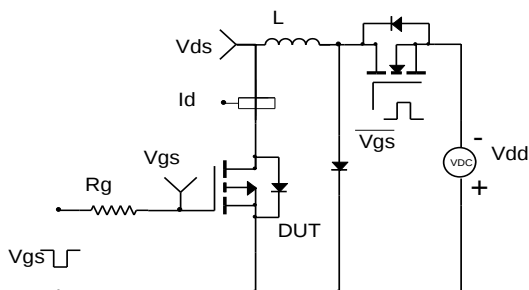
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

